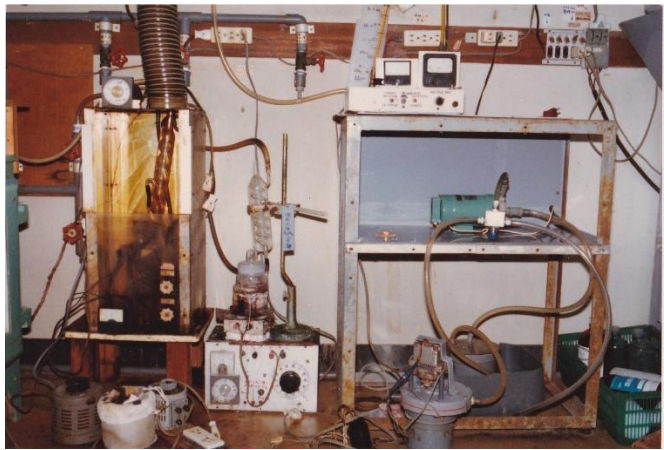
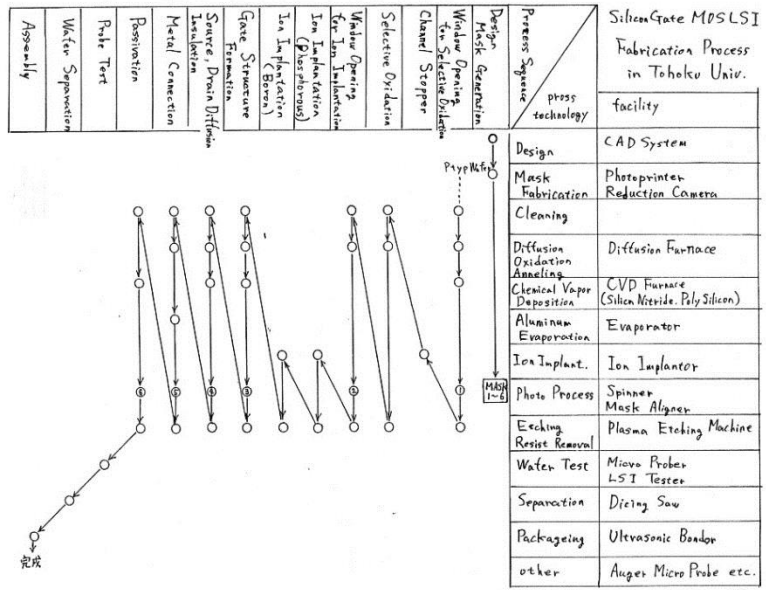
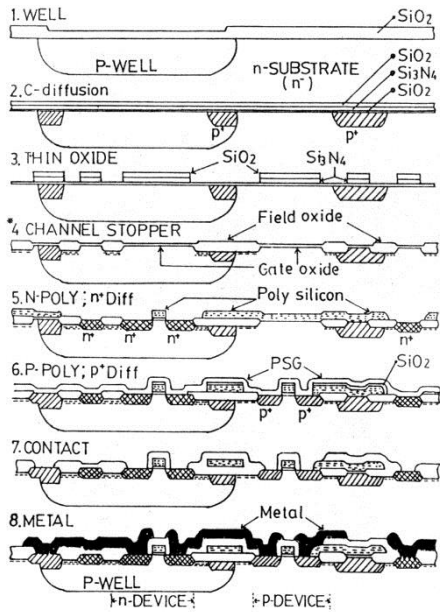
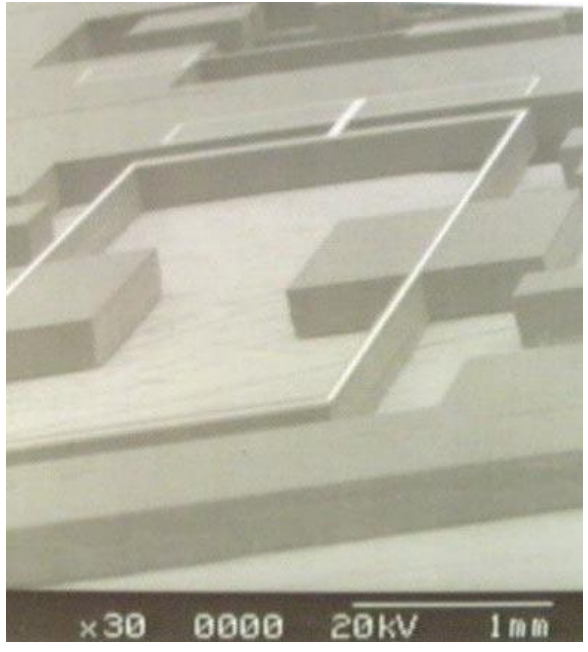
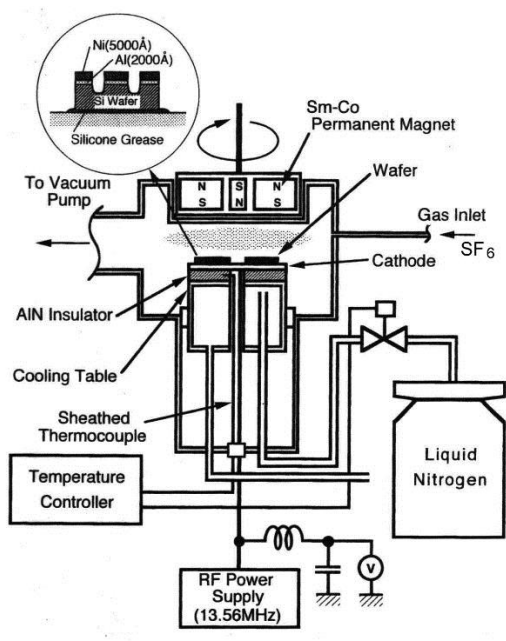


[3] Wafer process (etching, oxidation & diffusion, CVD, ion implantation, evaporation & sputter deposition)



Si EPW etcher, SiN etcher in hot phosphoric acid, Electrochemical Si etcher DI watersupply

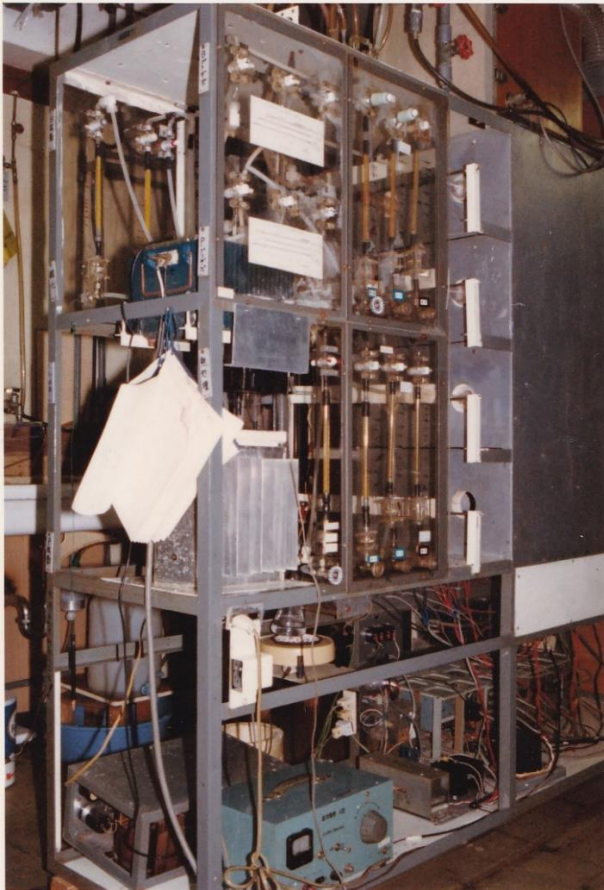


Si deep RIE (Reactive Ion Etching) system (1992)

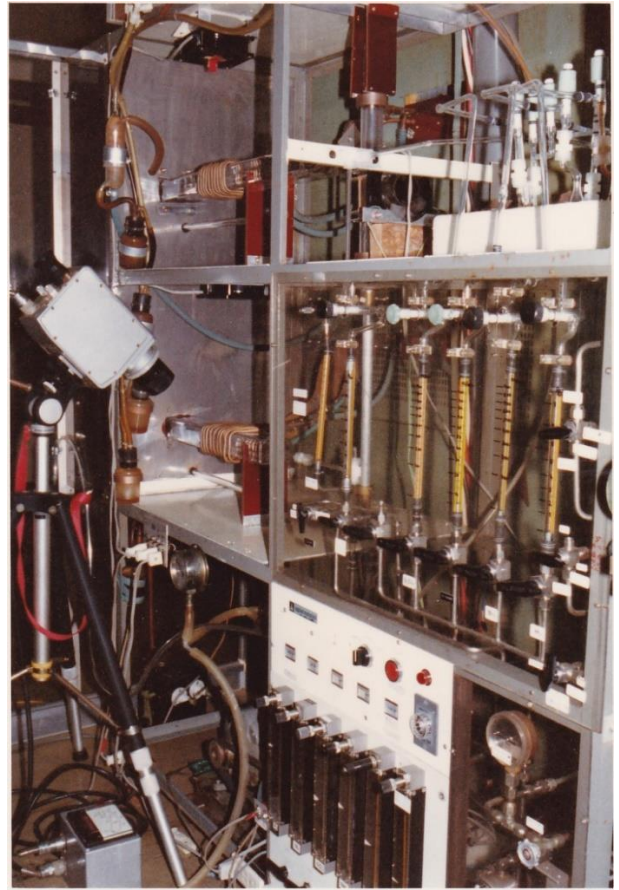
Resonating gyroscope by the deep RIE through Si wafer

(M.Takinami, K.Minami and M.Esashi : High-Speed Directional Low-Temp. Dry Etching for Bulk Silicon Micromachining, 11th Sensor Symp. (1992) 15-18)

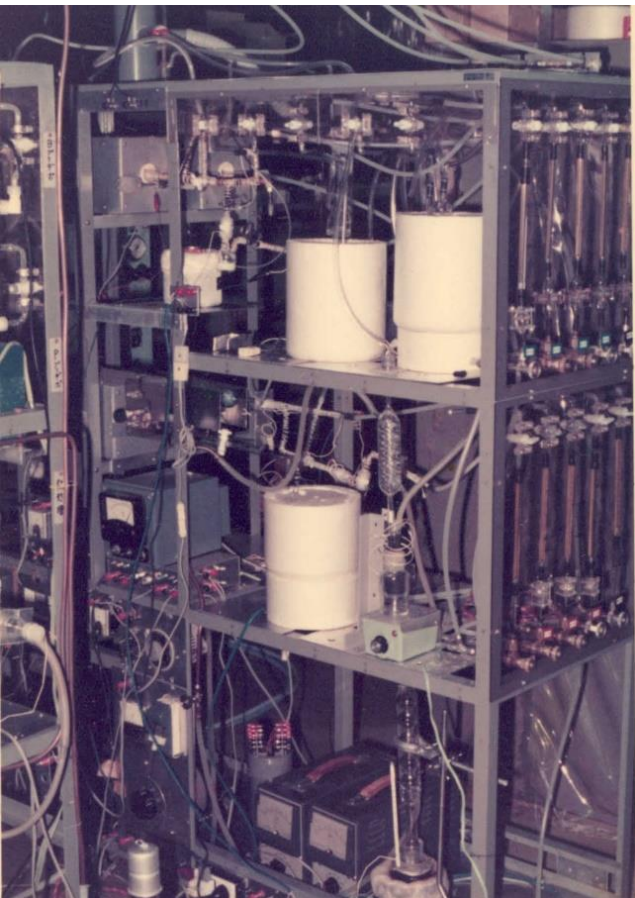
(J.Choi, K.Minami and M.Esashi : Application of Deep Reactive Ion Etching for Silicon Angular Rate Sensor, Microsystem Tech., 2, 4 (1996) 186-199)



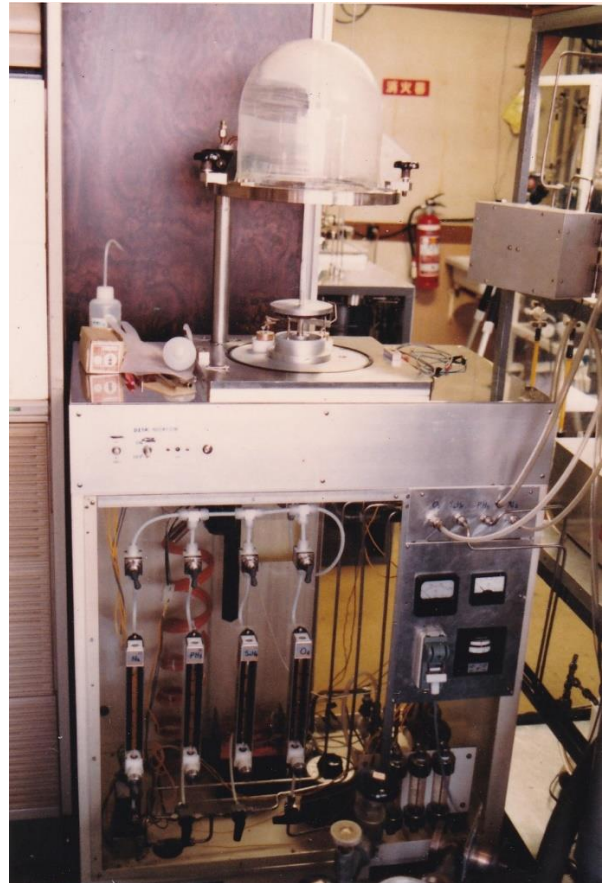
Oxidation diffusion furnace



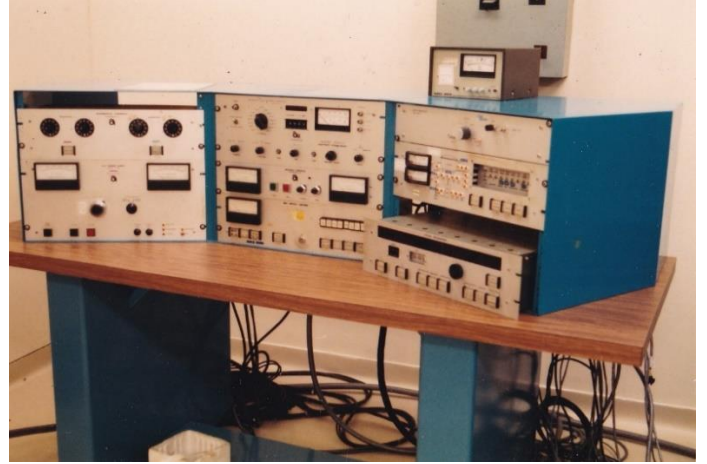
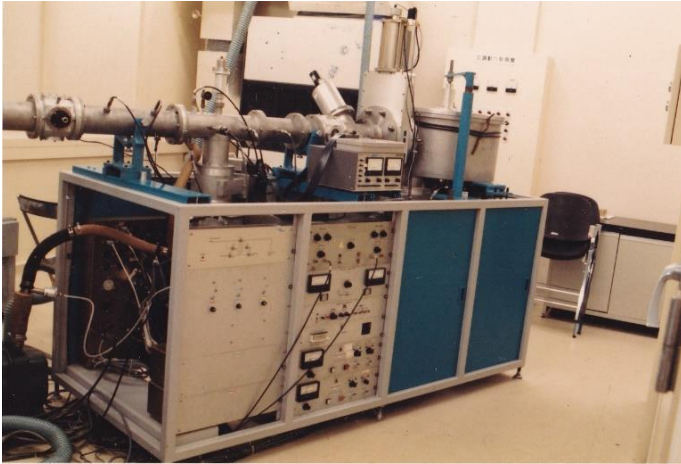
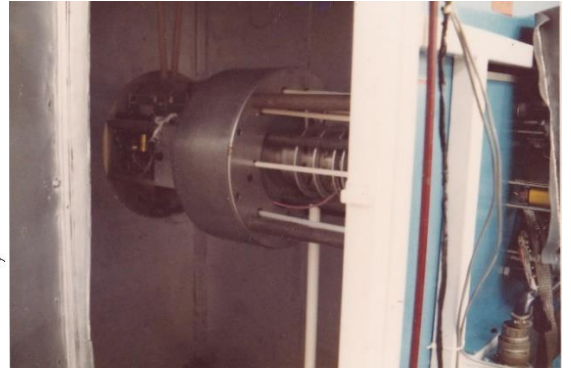
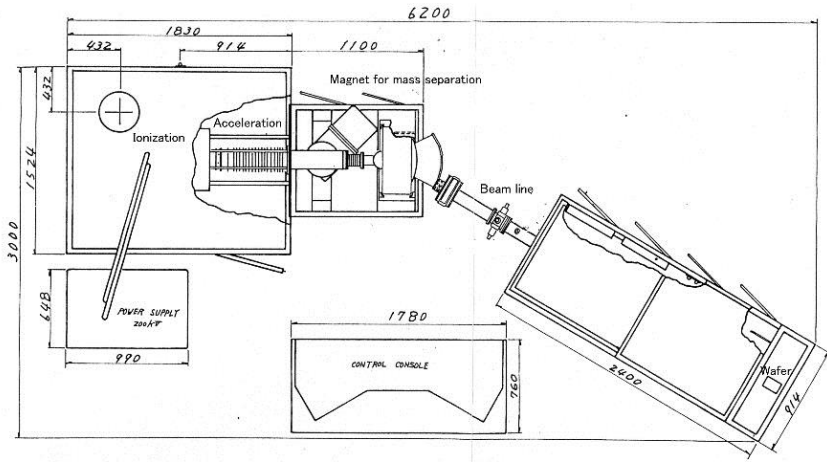
Atmospheric CVD for Si<sub>3</sub>N<sub>4</sub>, SiO<sub>2</sub>, Poly-Si (displayed)



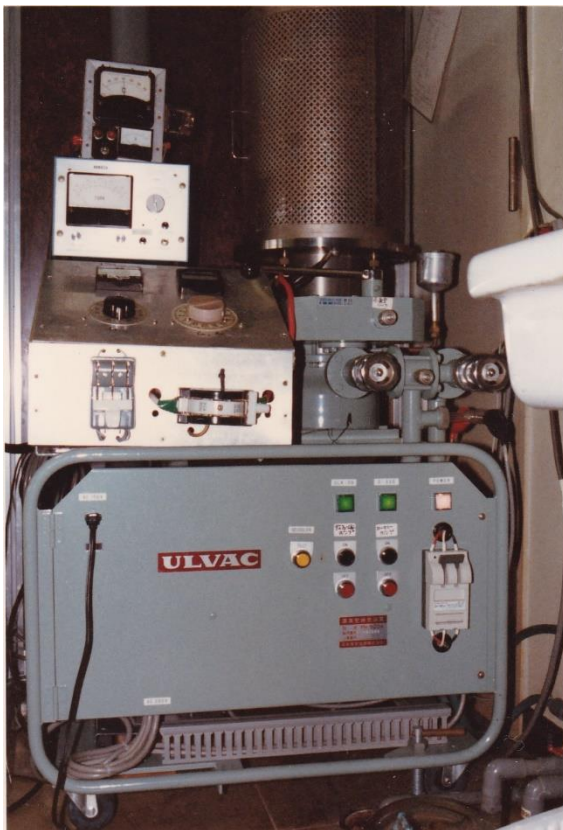
TEOS (tetraethoxysilane) source Al<sub>2</sub>O<sub>3</sub>-SiO<sub>2</sub> CVD



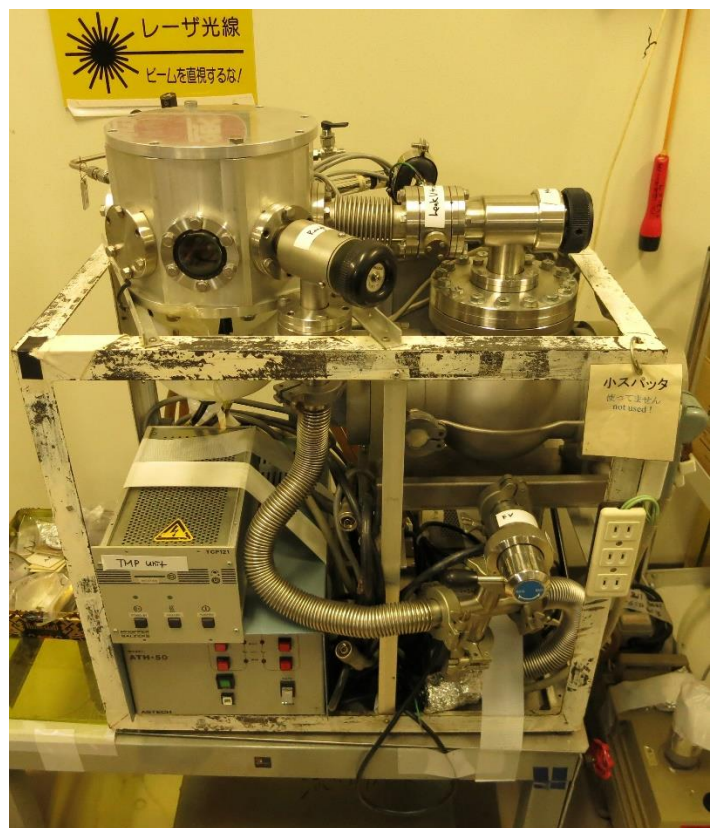
Low temperature CVD for SiO<sub>2</sub> (displayed)



Ion implanter (Accelerator Inc, 200MP second hand)



Al, Cr-Cu-Au evaporator



Magnetron sputter deposition